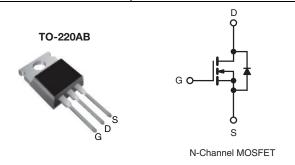


Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	400 V			
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	1.8		
Q _g (Max.) (nC)	20			
Q _{gs} (nC)	3.3			
Q _{gd} (nC)	11			
Configuration	Single			



FEATURES

- Dynamic dV/dt rating
- · Repetitive avalanche rated
- · Fast switching
- · Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

This datasheet provides information about parts that are RoHS-compliant and/or parts that are non-RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information/tables in this datasheet for details.

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free	IRF720PbF
	SiHF720-E3
SnPb	IRF720
	SiHF720

PARAMETER	SYMBOL	LIMIT	UNIT	
Drain-Source Voltage	V _{DS}	400	V	
Gate-Source Voltage	V_{GS}	± 20	V	
Continuous Drain Current	V_{GS} at 10 V $T_C = 25 ^{\circ}\text{C}$	1-	3.3	
	$T_C = 100 ^{\circ}$ C	I _D	2.1	Α
Pulsed Drain Current ^a	I _{DM}	13		
Linear Derating Factor		0.40	W/°C	
Single Pulse Avalanche Energy b	E _{AS}	190	mJ	
Repetitive Avalanche Current ^a	I _{AR}	3.3	Α	
Repetitive Avalanche Energy ^a		E _{AR}	5.0	mJ
Maximum Power Dissipation	T _C = 25 °C	P_{D}	50	W
Peak Diode Recovery dV/dt ^c	dV/dt	4.0	V/ns	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55 to +150		
Soldering Recommendations (Peak Temperature) d	for 10 s		300	°C
Mounting Torque	C 00 av M0 asses		10	lbf ⋅ in
	6-32 or M3 screw		1.1	N · m

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD}=50$ V, starting $T_J=25$ °C, L=30 mH, $R_g=25$ Ω , $I_{AS}=3.3$ A (see fig. 12). c. $I_{SD}\leq 3.3$ A, $dI/dt\leq 65$ A/µs, $V_{DD}\leq V_{DS}$, $T_J\leq 150$ °C.

- d. 1.6 mm from case.



Vishay Siliconix

THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	62	
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	2.5	

PARAMETER	SYMBOL	TEST (MIN.	TYP.	MAX.	UNIT	
Static					ļ.		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		400	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	0.51	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	Vo	$a_{SS} = \pm 20$	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 400 V, V _{GS} = 0 V V _{DS} = 320 V, V _{GS} = 0 V, T _J = 125 °C		-	-	25 250	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V		-	-	1.8	Ω
Forward Transconductance	9 _{fs}	$V_{DS} = 50 \text{ V}, I_{D} = 2.0 \text{ A}^{\text{b}}$		1.7	-	-	S
Dynamic	013		, , ,		ļ		
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0 MHz, see fig. 5		-	410	-	pF
Output Capacitance	C _{oss}			-	120	-	
Reverse Transfer Capacitance	C _{rss}			-	47	-	
Total Gate Charge	Qq		In = 3.3 A.	-	-	20	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$V_{DS} = 320 \text{ V},$	-	-	3.3	
Gate-Drain Charge	Q _{gd}	see fig. 6 and 13 b	-	-	11	1	
Turn-On Delay Time	t _{d(on)}			-	10	-	
Rise Time	t _r	\/ = 20	V 200 V I 2.2 A		14	-	- ns
Turn-Off Delay Time	t _{d(off)}	V_{DD} = 200 V, I_{D} = 3.3 A R_{g} = 18 Ω , R_{D} = 56 Ω , see fig. 10 ^b		-	30	-	
Fall Time	t _f			-	13	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	ml l
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		_	-	3.3	- A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	13	
Body Diode Voltage	V _{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 3.3 \text{A}, V_{GS} = 0 \text{V}^{ \text{b}}$		-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	T - 25 °C 1 2	2.2.4. dl/dt = 100.4/ h	-	270	600	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 3.3 \text{A}, dI/dt = 100 \text{A/}\mu\text{s}^{ \text{b}}$		-	1.4	3.0	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-	on time is negligible (turn	ı-on is doı	minated b	by L _S and	L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

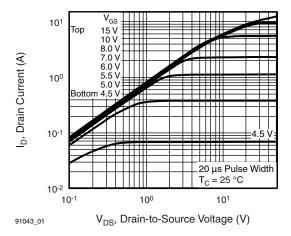


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

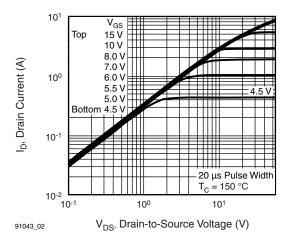


Fig. 2 - Typical Output Characteristics, $T_C = 150 \, ^{\circ}\text{C}$

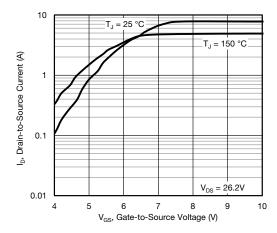


Fig. 3 - Typical Transfer Characteristics

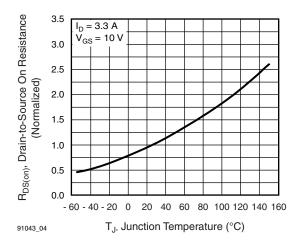


Fig. 4 - Normalized On-Resistance vs. Temperature

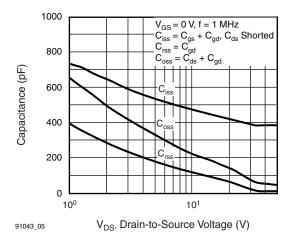


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

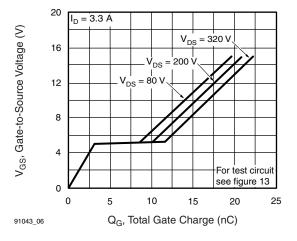


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



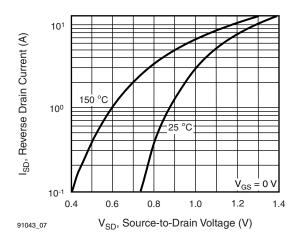


Fig. 7 - Typical Source-Drain Diode Forward Voltage

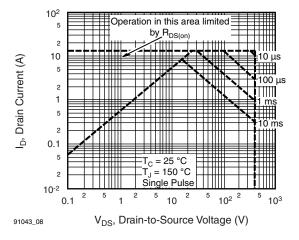


Fig. 8 - Maximum Safe Operating Area

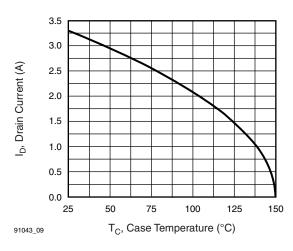


Fig. 9 - Maximum Drain Current vs. Case Temperature

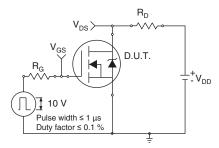


Fig. 10a - Switching Time Test Circuit

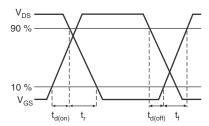


Fig. 10b - Switching Time Waveforms

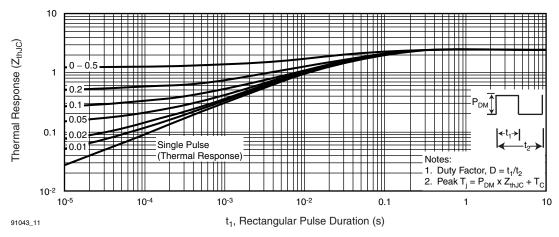


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



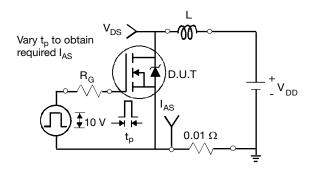


Fig. 12a - Unclamped Inductive Test Circuit

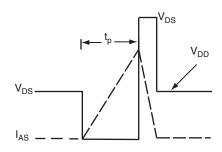


Fig. 12b - Unclamped Inductive Waveforms

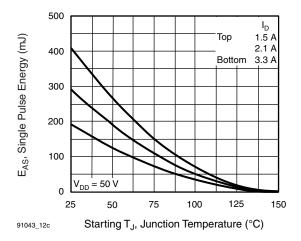


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

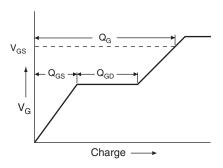


Fig. 13a - Basic Gate Charge Waveform

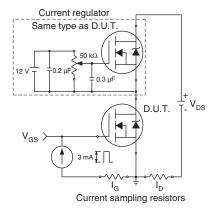
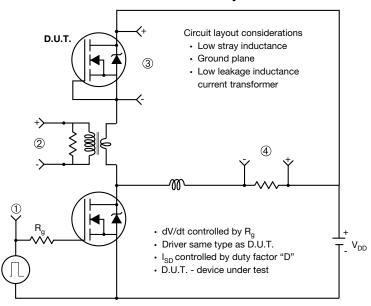


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



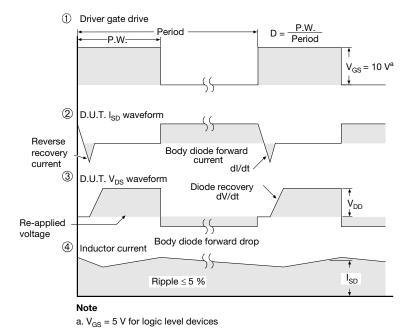


Fig. 14 - For N-Channel

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